


<b>Search Notes</b>  	<b>Application/Control No.</b>  10806606	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAI, EIJI
	<b>Examiner</b>  Tekle, Daniel	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	112, 77	08/24/07	D.T.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST SEARCH DATA BASE (US-PGPUB; USPAT; USOCR; DERWENT; IBM_TDB)	08/24/07	D.T.
SEARCH QUERY (WRITE OR READ; NON-VOLATILE; POWER WITH FAIL OR DISCONTINUE OR INTERRUPTION)	08/24/07	D.T.
COMBINED CITATION	08/27/07	D.T.
INVENTOR SEARCH	08/27/07	D.T.
SEARCH UPDATED	05/10/08	D.T.
SEARCH UPDATED	12/03/08	D.T.
SEARCH UPDATED	06/06/09	D.T.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/DANIEL TEKLE/ Examiner.Art Unit 2621	
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